# <u>MOSFET</u> – Power, P-Channel, SOT-223

## -10 A, -20 V

#### Features

- Low R<sub>DS(on)</sub>
- Logic Level Gate Drive
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- NVF Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable\*
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

• Power Management in Portables and Battery–Powered Products, i.e.: Cellular and Cordless Telephones and PCMCIA Cards

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	-20	Vdc		
Gate-to-Source Voltage	V <sub>GS</sub>	±8.0	Vdc		
Drain Current (Note 1) – Continuous @ T <sub>A</sub> = 25°C – Continuous @ T <sub>A</sub> = 70°C – Single Pulse (t <sub>p</sub> = 10 μs)	I <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	-10 -8.4 -35	Adc Apk		
Total Power Dissipation @ $T_A = 25^{\circ}C$	PD	8.3	W		
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	−55 to +150	°C		
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy} &- \mbox{Starting } T_J = 25^\circ C \\ \mbox{(V}_{DD} = -20 \mbox{ Vdc}, \mbox{V}_{GS} = -5.0 \mbox{ Vdc}, \\ \mbox{I}_{L(pk)} = -10 \mbox{ A}, \mbox{L} = 3.0 \mbox{ mH}, \mbox{ R}_G = 25\Omega ) \end{array} $	E <sub>AS</sub>	150	mJ		
Thermal Resistance – Junction to Lead (Note 1) – Junction to Ambient (Note 2) – Junction to Ambient (Note 3)	$f{R}_{ heta JL} \ f{R}_{ heta JA} \ f{R}_{ heta JA}$	15 71.4 160	°C/W		
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

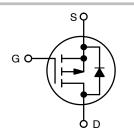
- 1. Steady State.
- 2. When surface mounted to an FR4 board using 1" pad size, (Cu. Area 1.127 sq in), Steady State.
- 3. When surface mounted to an FR4 board using minimum recommended pad size, (Cu. Area 0.412 sq in), Steady State.



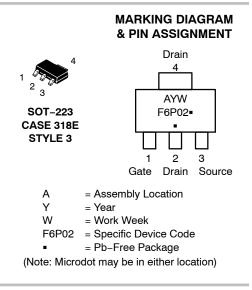
## **ON Semiconductor®**

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-10 AMPERES -20 VOLTS R<sub>DS(on)</sub> = 44 mΩ (Typ.)



P-Channel MOSFET



#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTF6P02T3G	SOT-223 (Pb-Free)	4000 / Tape & Reel
NVF6P02T3G*	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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### ELECTRICAL CHARACTERISTICS (T<sub>.1</sub> = 25°C unless otherwise noted)

Cha	Symbol	Min	Тур	Мах	Unit	
OFF CHARACTERISTICS		•				
Drain-to-Source Breakdown Voltage (Note 4) ( $V_{GS} = 0 \text{ Vdc}, I_D = -250 \mu \text{Adc}$ ) Temperature Coefficient (Positive)		V <sub>(BR)DSS</sub>	-20 -	-25 -11		Vdc mV/°C
Zero Gate Voltage Drain Current ( $V_{DS} = -20$ Vdc, $V_{GS} = 0$ Vdc) ( $V_{DS} = -20$ Vdc, $V_{GS} = 0$ Vdc, $T_J = 125^{\circ}$ C)					-1.0 -10	μAdc
$ \begin{array}{l} \mbox{Gate-Body Leakage Current} \\ \mbox{(V}_{GS}=\pm 8.0 \mbox{ Vdc}, \mbox{V}_{DS}=0 \mbox{ Vdc}) \end{array} $			-	-	± 100	nAdc
ON CHARACTERISTICS (Note 4)						
Gate Threshold Voltage (Note 4) $(V_{DS} = V_{GS}, I_D = -250 \ \mu Adc)$ Threshold Temperature Coefficient (Negative)		V <sub>GS(th)</sub>	-0.4	-0.7 2.6	-1.0 -	Vdc mV/°C
$\begin{array}{l} \mbox{Static Drain-to-Source On-Resistance (Note 4)} \\ (V_{GS} = -4.5 \mbox{ Vdc}, \mbox{ I}_D = -6.0 \mbox{ Adc}) \\ (V_{GS} = -2.5 \mbox{ Vdc}, \mbox{ I}_D = -4.0 \mbox{ Adc}) \\ (V_{GS} = -2.5 \mbox{ Vdc}, \mbox{ I}_D = -3.0 \mbox{ Adc}) \end{array}$		R <sub>DS(on)</sub>	- - -	44 57 57	50 70 -	mΩ
Forward Transconductance (Note 4) $(V_{DS} = -10 \text{ Vdc}, I_D = -6.0 \text{ Adc})$		9 <sub>fs</sub>	-	12	_	Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ V},$	C <sub>iss</sub>	-	900	1200	pF
Output Capacitance	f = 1.0 MHz)	C <sub>oss</sub>	-	350	500	
Transfer Capacitance		C <sub>rss</sub>	-	90	150	
Input Capacitance	(V <sub>DS</sub> = -10 Vdc, V <sub>GS</sub> = 0 V, f = 1.0 MHz)	C <sub>iss</sub>	-	940	-	pF
Output Capacitance	I = 1.0 (WHZ)	C <sub>oss</sub>	-	410	-	
Transfer Capacitance		C <sub>rss</sub>	-	110	-	
SWITCHING CHARACTERISTICS	<b>S</b> (Note 5)					
Turn-On Delay Time	$(V_{DD} = -5.0 \text{ Vdc}, I_D = -1.0 \text{ Adc},$	t <sub>d(on)</sub>	_	7.0	12	ns
Rise Time	V <sub>GS</sub> = -4.5 Vdc, R <sub>G</sub> = 6.0 Ω)	t <sub>r</sub>	-	25	45	1
Turn-Off Delay Time		t <sub>d(off)</sub>	-	75	125	]
Fall Time		t <sub>f</sub>	-	50	85	]
Turn-On Delay Time	$(V_{DD} = -16 \text{ Vdc}, I_D = -6.0 \text{ Adc},$	t <sub>d(on)</sub>	-	8.0	-	ns
Rise Time	V <sub>GS</sub> = -4.5 Vdc, R <sub>G</sub> = 2.5 Ω)	t <sub>r</sub>	-	30	-	
<b>T</b> 0" <b>D</b>   <b>T</b>				00		7

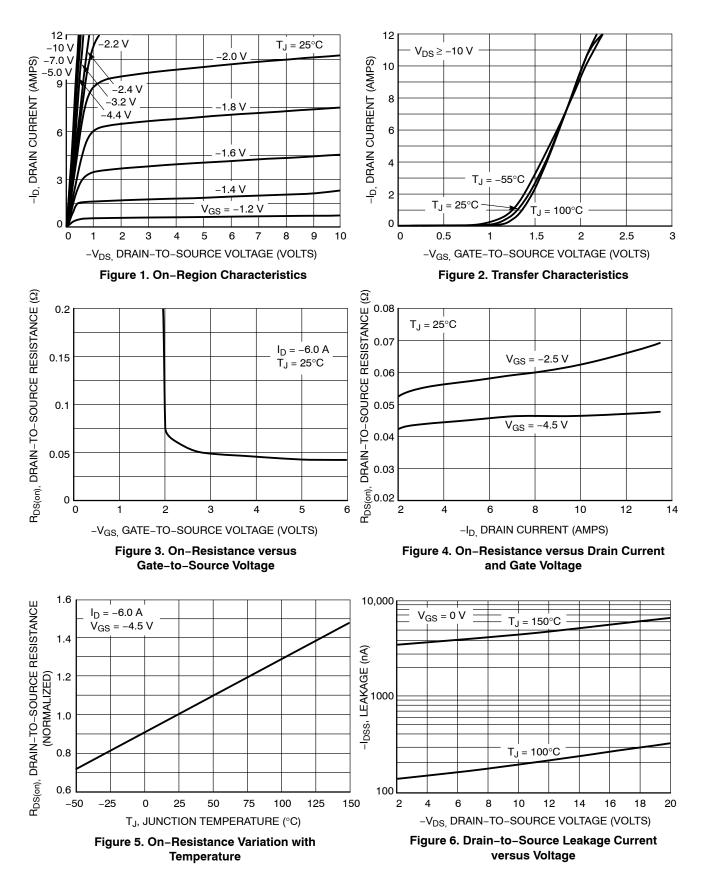
	1 ig - 2.0 iii)					
Turn-Off Delay Time		t <sub>d(off)</sub>	-	60	-	
Fall Time		t <sub>f</sub>	-	60	-	
Gate Charge	(V <sub>DS</sub> = -16 Vdc, I <sub>D</sub> = -6.0 Adc, V <sub>GS</sub> = -4.5 Vdc) (Note 4)	Q <sub>T</sub>	-	15	20	nC
	$v_{GS} = -4.5$ Vdc) (Note 4)	Q <sub>gs</sub>	-	1.7	-	
		Q <sub>gd</sub>	-	6.0	-	

#### SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage		V <sub>SD</sub>	- - -	-0.82 -0.74 -0.68	-1.2 - -	Vdc
Reverse Recovery Time	$(I_{\rm S} = -3.0 \text{ Adc}, V_{\rm GS} = 0 \text{ Vdc},$	t <sub>rr</sub>	-	42	_	ns
	dI <sub>S</sub> /dt = 100 A/µs) (Note 4)	t <sub>a</sub>	-	17	-	
		t <sub>b</sub>	-	25	_	
Reverse Recovery Stored Charge		Q <sub>RR</sub>	-	0.036	-	μC

4. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%. 5. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL ELECTRICAL CHARACTERISTICS**



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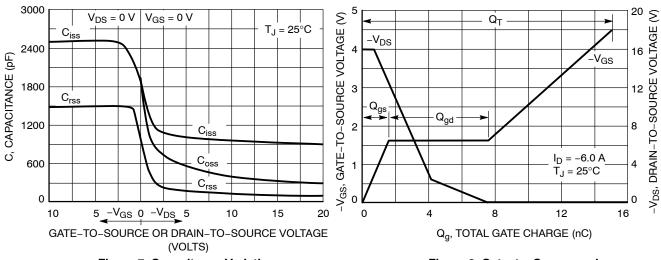


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

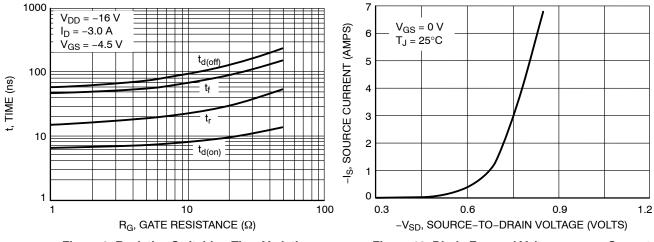


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

### **TYPICAL ELECTRICAL CHARACTERISTICS**

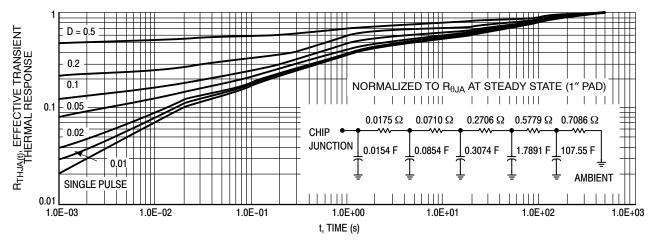


Figure 11. FET Thermal Response

DATE 02 OCT 2018

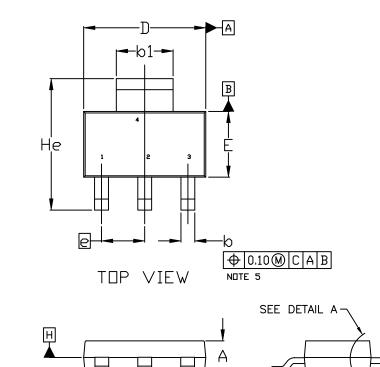




SCALE 1:1

0.10 C

A1



-11

SIDE VIEW

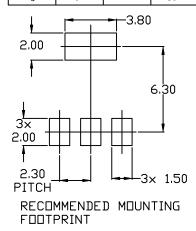
DETAIL A

NDTES:

SOT-223 (TO-261) CASE 318E-04 ISSUE R

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. ALLS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
b	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
с	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
e	i	2.30 BSC	;	
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0*		10°	



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FRONT VIEW

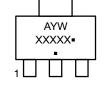
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#### SOT-223 (TO-261) CASE 318E-04 ISSUE R

#### DATE 02 OCT 2018

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	Style 9: Pin 1. Input 2. Ground 3. Logic 4. Ground	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	Style 12: Pin 1. Input 2. Output 3. NC 4. Output	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

## GENERIC MARKING DIAGRAM\*



- A = Assembly Location
- Y = Year
- W = Work Week
- XXXXX = Specific Device Code
- = Pb-Free Package
- (Note: Microdot may be in either location) \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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